Notice of References Cited Application/Control No. 10/027,870 Examiner David Buttner Applicant(s)/Patent Under Reexamination WARTH ET AL. Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0112520	06-2003	Takahashi et al.	359/603
	В	US-			
	C	US-			
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	Е	US-			
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